

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/245,603	CURIEL ET AL.	
Examiner	Art Unit	
Kimberly A. Makar, Ph.D.	1636	

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SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
INTER	PRENCE	4/216	07 KAR	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST: USPAT; US PGPUB; USOCR; JPO; EPO; IBM_TDB; DERWENT	6/21/2007	КАМ		
STN: medline, biosis, embase, caplus	6/21/2007	КАМ		
PALM inventor search	6/21/2007	KAM		
STIC Interference Sequence search. Results available at: http://es/ScoreAcessWeb/Search.vm	6/17/2007	kam		